

# MOS FIELD EFFECT TRANSISTOR 2SK3295

# SWITCHING N-CHANNEL POWER MOS FET INDUSTRIAL USE

### **DESCRIPTION**

The 2SK3295 is N-Channel MOS FET device that features a low on-state resistance and excellent switching characteristics, designed for low voltage high current applications such as DC/DC converter with synchronous rectifier.

### **FEATURES**

- 4.5 V drive available
- · Low on-state resistance

 $R_{DS(on)1} = 18 \text{ m}\Omega \text{ MAX.} \text{ (Vgs} = 10 \text{ V, ID} = 18 \text{ A)}$ 

- · Low gate charge
  - $Q_G = 16 \text{ nC TYP.}$  ( $I_D = 35 \text{ A}$ ,  $V_{DD} = 16 \text{ V}$ ,  $V_{GS} = 10 \text{ V}$ )
- Built-in gate protection diode
- · Surface mount device available

# **★ ORDERING INFORMATION**

PART NUMBER	PACKAGE
2SK3295	TO-220AB
2SK3295-S	TO-262
2SK3295-ZK	TO-263(MP-25ZK)
2SK3295-ZJ	TO-263(MP-25ZJ)

## ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

Drain to Source Voltage (Vgs = 0 V)	VDSS	20	V
Gate to Source Voltage (V <sub>DS</sub> = 0 V)	Vgss	±20	V
Drain Current (DC) (Tc = 25°C)	ID(DC)	±35	Α
Drain Current (Pulse) Note	D(pulse)	±140	Α
Total Power Dissipation (T <sub>A</sub> = 25°C)	P <sub>T1</sub>	1.5	W
Total Power Dissipation (Tc = 25°C)	P <sub>T2</sub>	35	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	-55 to +150	°C

**Note** PW  $\leq$  10  $\mu$ s, Duty Cycle  $\leq$  1%

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Not all devices/types available in every country. Please check with local NEC representative for availability and additional information.



**ELECTRICAL CHARACTERISTICS(TA = 25°C)** 

CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	IDSS	VDS = 20 V, VGS = 0 V			10	μΑ
Gate Leakage Current	Igss	Vgs = ±20 V, Vps = 0 V			±10	μΑ
Gate Cut-off Voltage	V <sub>GS(off)</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA	1.0		2.5	V
Forward Transfer Admittance	yfs	VDS = 10 V, ID = 18 A	7.5			S
Drain to Source On-state Resistance	RDS(on)1	Vgs = 10 V, ID = 18 A		13	18	mΩ
	RDS(on)2	Vgs = 4.5 V, lp = 18 A		21	27	mΩ
Input Capacitance	Ciss	V <sub>DS</sub> = 10 V		720		pF
Output Capacitance	Coss	V <sub>G</sub> S = 0 V		370		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		180		pF
Turn-on Delay Time	t <sub>d(on)</sub>	VDD = 10 V , ID = 18 A		85		ns
Rise Time	tr	V <sub>GS(on)</sub> = 10 V		2000		ns
Turn-off Delay Time	t <sub>d(off)</sub>	$R_G = 10 \Omega$		65		ns
Fall Time	tf			270		ns
Total Gate Charge	Q <sub>G</sub>	VDD = 16 V		16		nC
Gate to Source Charge	QGS	Vgs = 10 V		3.1		nC
Gate to Drain Charge	Q <sub>GD</sub>	ID = 35 A		5.2		nC
Body Diode Forward Voltage	V <sub>F(S-D)</sub>	IF = 35 A, VGS = 0 V		1.0		V
Reverse Recovery Time	trr	IF = 35 A, VGS = 0 V		28		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/μs		14		nC

90%

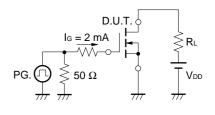
90%

10%

## **TEST CIRCUIT 1 SWITCHING TIME**

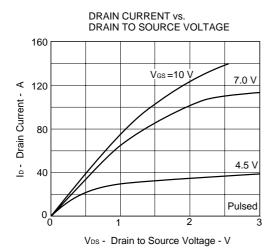
# PG. $\bigcirc$ RG $\bigcirc$ VGS $\bigcirc$

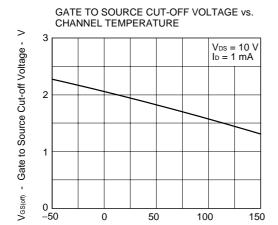
# **TEST CIRCUIT 2 GATE CHARGE**



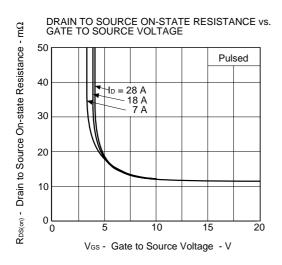


## **★** TYPICAL CHARACTERISTICS (T<sub>A</sub> = 25°C)

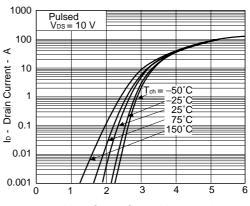




Tch - Channel Temperature - °C

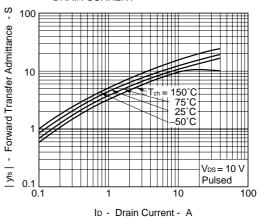


### FORWARD TRANSFER CHARACTERISTICS



 $V_{\text{GS}}$  - Gate to Source Voltage -  $\,V\,$ 

# FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT

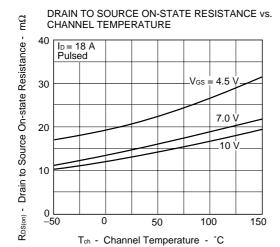
50
Pulsed

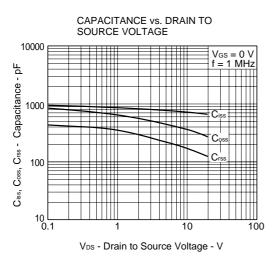
Pulsed

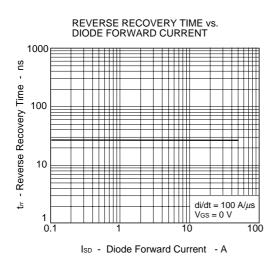
70
Pulsed

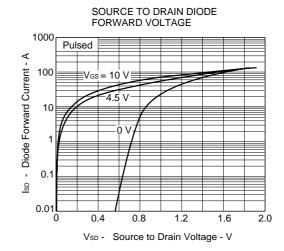
10
10
10
10
100
1000

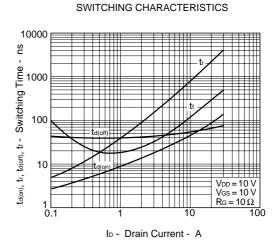
10 - Drain Current - A

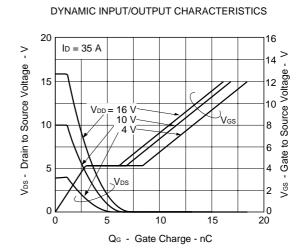


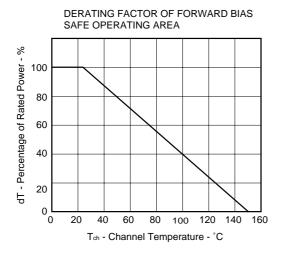


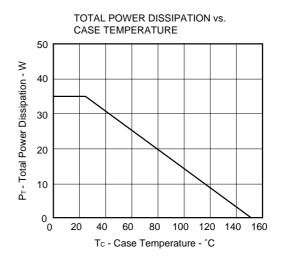




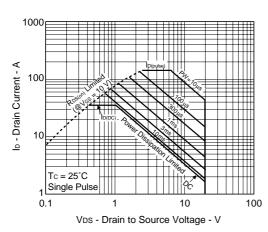




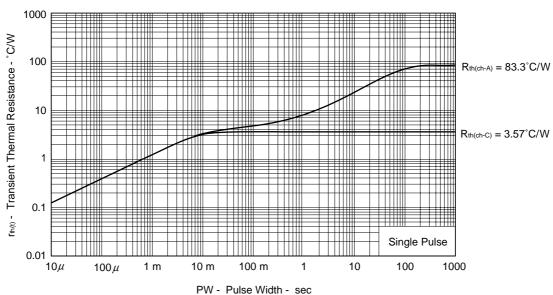




### FORWARD BIAS SAFE OPERATING AREA



### TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

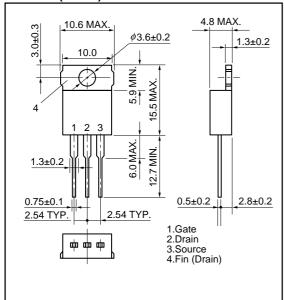


5

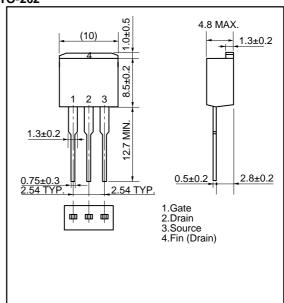


### PACKAGE DRAWINGS (Unit: mm)

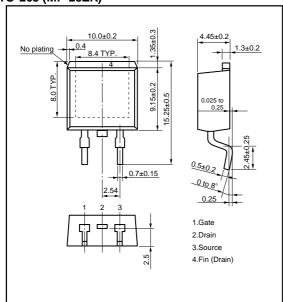
### 1)TO-220AB (MP-25)



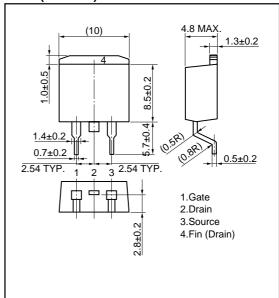
### 2)TO-262



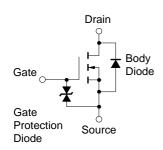
### 3)TO-263 (MP-25ZK)



# 4)TO-263 (MP-25ZJ)



# **EQUIVALENT CIRCUIT**



**Remark** The diode connected between the gate and source of the transistor serves as a protector against ESD.

> When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

**NEC** 2SK3295

[MEMO]

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